

FORM PTO-1449  
(Modified)U.S. Department of Commerce  
Patent and Trademark Office

Attorney Docket No.: S51-00501

Serial No.: 09/912,844

INFORMATION DISCLOSURE STATEMENT BY APPLICANT  
(Use Several Sheets If Necessary)Applicant: Maximilian Biberger *et al.*

(37 CFR § 1.98(b))

Filing Date: July 24, 2001

Group Art Unit: 2812

## U.S. PATENT DOCUMENTS

Examiner Initials		Serial / Patent Number	Issue Date	Applicant / Patentee	Class	Subclass	Filing Date
Pu	AA	4,788,043	11/29/88	Kagiyama <i>et al.</i>	422	292	04/17/86
Pu	AB	4,944,837	07/31/90	Nishikawa <i>et al.</i>	156	646	02/28/89
Pu	AC	5,013,366	05/07/91	Jackson <i>et al.</i>	134	1	12/07/88
Pu	AD	5,068,040	11/26/91	Jackson	210	748	04/03/89
Pu	AE	5,143,103	09/01/92	Basso <i>et al.</i>	134	98.1	01/04/91
Pu	AF	5,185,296	02/09/93	Morita <i>et al.</i>	437	229	04/24/91
Pu	AG	5,213,619	05/25/93	Jackson <i>et al.</i>	134	1	11/30/89
Pu	AH	5,215,592	06/01/93	Jackson	134	1	01/22/91
Pu	AI	5,236,602	08/17/93	Jackson	210	748	01/28/91
Pu	AJ	5,237,824	08/24/93	Pawliszyn	62	51.1	10/12/90
Pu	AK	5,267,455	12/07/93	Deweese <i>et al.</i>	68	5C	07/13/92
Pu	AL	5,304,515	04/19/94	Morita <i>et al.</i>	437	231	08/07/92
Pu	AM	5,306,350	04/26/94	Hoy <i>et al.</i>	134	22.14	04/27/92
Pu	AN	5,313,965	05/24/94	Palen	134	61	06/01/92
Pu	AO	5,316,591	05/31/94	Chao <i>et al.</i>	134	34	08/10/92
Pu	AP	5,337,446	08/16/94	Smith <i>et al.</i>	15	21.1	10/27/92
Pu	AQ	5,355,901	10/18/94	Mielnik <i>et al.</i>	134	105	10/27/92
Pu	AR	5,368,171	11/29/94	Jackson	134	147	07/20/92
Pu	AS	5,370,740	12/06/94	Chao <i>et al.</i>	134	1	10/01/93
Pu	AT	5,377,705	01/03/95	Smith, Jr. <i>et al.</i>	134	95.3	09/16/93
Pu	AU	5,401,322	03/28/95	Marshall	134	13	06/30/92
Pu	AV	5,403,621	04/4/95	Jackson <i>et al.</i>	427	255.1	10/01/93
Pu	AW	5,417,768	05/23/95	Smith, Jr. <i>et al.</i>	134	10	12/14/93
Pu	AX	5,456,759	10/10/95	Stanford, Jr. <i>et al.</i>	134	1	08/01/94
Pu	AY	5,494,526	02/27/96	Paranjpe	134	1	05/04/95
Pu	AZ	5,500,081	03/19/96	Bergman	156	646.1	12/05/94
Pu	BA	5,501,761	03/26/96	Evans <i>et al.</i>	156	344	10/18/94
Pu	BB	5,522,938	06/04/96	O'Brien	134	1	08/08/94
Pu	BC	5,526,834	06/18/96	Mielnik <i>et al.</i>	134	105	08/17/94
Pu	BD	5,533,538	07/09/96	Marshall	134	104.4	12/01/94
Pu	BE	5,683,977	11/04/97	Jureller <i>et al.</i>	510	286	03/06/95
Pu	BF	5,797,719	08/25/98	James <i>et al.</i>	417	46	10/30/96
Pu	BG	5,868,856	02/09/99	Douglas <i>et al.</i>	134	2	07/23/97
Pu	BH	5,868,862	02/09/99	Douglas <i>et al.</i>	134	26	07/31/97
Pu	BI	5,881,577	03/16/99	Sauer <i>et al.</i>	68	5	09/09/96
Pu	BJ	5,888,050	03/30/99	Fitzgerald <i>et al.</i>	417	46	08/25/98

Examiner:

Rao

Date Considered:

10-21-2002

EXAMINER:

Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Applicant: Maximilian Biberger *et al.*

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**U.S. PATENT DOCUMENTS**

Examiner	Serial / Patent Number	Issue Date	Applicant / Patentee	Class	Subclass	Filing Date
<i>RK</i>	5,900,354	05/04/99	Batchelder	430	395	07/03/97
<i>RK</i>	5,908,510	06/01/99	McCullough <i>et al.</i>	134	2	10/16/96
<i>RK</i>	5,976,264	11/02/99	McCullough <i>et al.</i>	134	2	11/30/98
<i>RK</i>	5,980,648	11/09/99	Adler	134	34	12/30/93
<i>RK</i>	6,024,801	02/15/00	Wallace <i>et al.</i>	134	1	12/09/96
<i>RK</i>	6,149,828	11/21/00	Vaartstra	216	57	05/05/97
<i>RK</i>	6,242,165 B1	06/05/01	Vaartstra	430	329	08/28/98

**FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS**

	Document Number	Publication Date	Country / Patent Office	Class	Subclass	Translation	
						Yes	No
<i>RK</i>	BR	WO 99/49998	10/07/99	WIPO	B08B	5/00	X
<i>RK</i>	BS	WO 01/78911 A1	10/25/01	WIPO	B08B	3/00	X

**OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)**

<i>RK</i>	BT	J.B. Rubin <i>et al.</i> "A Comparison of Chilled DI Water/Ozone and Co2-Based Supercritical Fluids as Replacements for Photoresist-Stripping Solvents" 1998, pp. 308-314, IEEE/CPMT Int'l Electronics Manufacturing Technology Symposium.
<i>RK</i>	BU	Cleaning with Supercritical CO <sub>2</sub> , NASA Tech Briefs, MFS-29611, Marshall Space Flight Center, Alabama, March 1979.
<i>RK</i>	BV	Russick, E.M. <i>et al.</i> , "Supercritical Carbon Dioxide Extraction of Solvent from Micromachined Structures." Supercritical Fluids Extraction and Pollution Prevention, ACS Symposium Series, Vol. 670, pp. 255-269, 21 Oct 1997
<i>RK</i>	BW	McHardy, J. <i>et al.</i> , "Progress in Supercritical CO <sub>2</sub> Cleaning," SAMPE Jour., Vol. 29, No. 5, pp. 20-27, September 1993
<i>RK</i>	BX	Bok, E. <i>et al.</i> , "Supercritical Fluids for Single Wafer Cleaning," Solids State Technology, pp. 117-120, June 1992
<i>RK</i>	BY	Hansen, B.N. <i>et al.</i> , "Supercritical Fluid Transport - Chemical Deposition of Films," Chem. Mater., Vol. 4, No. 4, pp. 749-752, 1992
<i>RK</i>	BZ	Hybertson, B.M. <i>et al.</i> , "Deposition of Palladium Films by a Novel Supercritical Fluid Transport Chemical Deposition Process," Mat. Res. Bull., Vol. 26, pp. 1127-1133, 1991.
<i>RK</i>	CA	Ziger, D. H. <i>et al.</i> , "Compressed Fluid Technology: Application to RIE-Developed Resists," AiChE Jour., Vol. 33, No. 10, pp. 1585- 1591, October 1987.

Examiner: *Ramona*

Date Considered: 10-21-2002

**EXAMINER:** Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.RECEIVED  
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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (Use Extra Sheets If Necessary)				Applicant: Maximilian A. Biberger et al.				
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<b>U.S. PATENT DOCUMENTS</b>								
Examiner Initials		Serial / Patent Number	Issue Date	Applicant / Patentee	Class	Subclass	Filing Date	
RV	AA	5,314,574	05/24/94	Takahashi	156	646	06/25/93	
RV	AB	5,328,722	07/12/94	Ghanayem et al.	427	250	11/06/92	
RV	AC	5,955,140	09/21/99	Smith et al.	427	96	11/14/96	
	AD							
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	AP							
<b>FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS</b>								
		Document Number	Publication Date	Country / Patent Office	Class	Subclass	Translation	
							Yes	No
RV	AQ	2000 - 106358	04/11/00	JP	HO1L	21/3065		
RV	AR	WO 01/10733 A1	2/15/01	PCT	B65D	55/00		
RV	AS	WO 01/33615 A3	5/10/01	PCT	HO1L	21/00		
<b>OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)</b>								
	AT							
	AU							
	AV							
	AW							
	AX							
	AY							
	AZ							
Examiner: <u>R</u>				Date Considered: <u>10-21-2002</u>				
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